

| | | | | |
|-----------------------------------|--|---------------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination WANG, HUA-CHIANG | |
| | | Examiner Christopher Verdier | Art Unit 3745 | Page 1 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------|----------------|
| | A | US-2,160,278 A | 05-1939 | NESS et. al. | 417/371 |
| | B | US-6,705,833 B2 | 03-2004 | Tam et al. | 415/146 |
| | C | US-1,364,360 A | 01-1921 | EMERY | 417/234 |
| | D | US-6,655,926 B2 | 12-2003 | Wang et al. | 417/234 |
| | E | US-5,105,731 A | 04-1992 | Kraus | 454/259 |
| | F | US-5,167,574 A | 12-1992 | Ikeda et al. | 454/164 |
| | G | US-2,135,827 A | 11-1938 | MARTY | 415/206 |
| | H | US-2,548,607 A | 04-1951 | JENN | 454/353 |
| | I | US-2,741,972 A | 04-1956 | PRYNE | 454/353 |
| | J | US-3,384,000 A | 05-1968 | FULLER | 454/353 |
| | K | US-2,297,049 A | 09-1942 | COTTON et. al. | 417/423.14 |
| | L | US-165,517 A | 07-1875 | Morrell | 165/102 |
| | M | US-6,514,053 B2 | 02-2003 | Takura et al. | 417/371 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | JP-4-208,347-A | 07-1992 | Japan | | 454/353 |
| | O | JP-4-158,160-A | 06-1992 | Japan | | 454/353 |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

| | | | | |
|-----------------------------------|--|---------------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination WANG, HUA-CHIANG | |
| | | Examiner Christopher Verdier | Art Unit 3745 | Page 2 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-6,439,861 B1 | 08-2002 | Shieh | 417/371 |
| | B | US-4,424,006 A | 01-1984 | Armbruster | 417/234 |
| | C | US-2,005,408 A | 06-1935 | ALLIN | 415/121.2 |
| | D | US-2003/0161722 A1 | 08-2003 | Galassi | 415/121.2 |
| | E | US-5,000,769 A | 03-1991 | Raguideau et al. | 415/121.2 |
| | F | US-2,048,911 A | 07-1936 | ZIMMERMAN | 415/121.2 |
| | G | US-5,174,048 A | 12-1992 | Shero | 415/206 |
| | H | US-5,403,152 A | 04-1995 | Trautloff et al. | 415/206 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.